

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 249596US2S DIV		SERIAL NO. New DIV Application	
LIST OF REFERENCES CITED BY APPLICANT					APPLICANT Hideo ANDO, et al.			
					FILING DATE Herewith			GROUP
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
RL	AA	5,440,631	08/1995	Akiyama, et al.				
RL	AB	5,771,334	06/1998	Yamauchi, et al.				
RL	AC	5,857,021	01/1999	Kataoka, et al.				
RL	AD	6,047,103	04/2000	Yamauchi, et al.				
RL	AE	6,088,312	07/2000	Utsumi, et al.				
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							
	AM							
	AN							
FOREIGN PATENT DOCUMENTS								
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION				
				YES	NO			
RL	AO	6-103317	04/15/94	Japan	x			
RL	AP	8-221948	08/30/1996	Japan (w/English Translation)	x			
RL	AQ	6-349248	12/1994	Japan				
	AR							
	AS							
	AT							
	AU							
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
RL	AW	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD09805001						
RL	AX	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD00103788						
RL	AY	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD00103787						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner				Date Considered				
Robert Chalmers				6/11/05				
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								